# **Power MOSFET** 68 Amps, 30 Volts

# **N-Channel DPAK**

#### **Features**

- Ultra Low R<sub>DS(on)</sub>
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Diode Exhibits High Speed, Soft Recovery
- Avalanche Energy Specified
- I<sub>DSS</sub> Specified at Elevated Temperature
- DPAK Mounting Information Provided
- Pb-Free Packages are Available

## **Applications**

- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery Powered Products: i.e., Computers, Printers, Cellular and Cordless Telephones, and PCMCIA Cards

# **MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	30	Vdc
Gate-to-Source Voltage - Continuous	$V_{GS}$	±20	Vdc
Thermal Resistance – Junction–to–Case Total Power Dissipation @ $T_C$ = 25°C Continuous Drain Current @ $T_C$ = 25°C (Note 4) Continuous Drain Current @ $T_C$ = 100°C	R <sub>0</sub> JC P <sub>D</sub> I <sub>D</sub>	1.65 75 68 43	°C/W W A A
Thermal Resistance – Junction–to–Ambient (Note 2) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 3)	R <sub>θJA</sub> PD ID ID IDM	67 1.87 11.3 7.1 36	, C/S & & & &
Thermal Resistance – Junction–to–Ambient (Note 1) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 100°C Pulsed Drain Current (Note 3)	R <sub>θJA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	120 1.04 8.4 5.3 28	°C/W W A A A
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ( $V_{DD} = 30$ Vdc, $V_{GS} = 10$ Vdc, Peak $I_L = 17$ Apk, $L = 5.0$ mH, $R_G = 25~\Omega$ )	E <sub>AS</sub>	722	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8 in from case for 10 seconds	T <sub>L</sub>	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

- 1. When surface mounted to an FR4 board using the minimum recommended
- pad size. When surface mounted to an FR4 board using 0.5 sq. in. drain pad size.
- Pulse Test: Pulse Width = 300 µs, Duty Cycle = 2%.
   Current Limited by Internal Lead Wires.

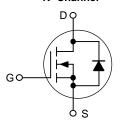


# ON Semiconductor®

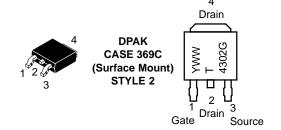
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
30 V	7.8 mΩ @ 10 V	68 A

#### N-Channel

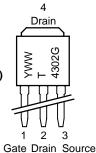


## **MARKING DIAGRAMS & PIN ASSIGNMENTS**





DPAK **CASE 369D** (Straight Lead) STYLE 2



= Year WW = Work Week T4302 = Device Code = Pb-Free Package

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Ch	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>				Vdc	
$(V_{GS} = 0 \text{ Vdc}, I_D = 250 \mu\text{A})$		30	- 25	_	~\//°C	
Positive Temperature Coefficient			_	23		mV/°C
Zero Gate Voltage Drain Current $(V_{GS} = 0 \text{ Vdc}, V_{DS} = 30 \text{ Vdc}, T$	I <sub>DSS</sub>	_	_	1.0	μAdc	
$(V_{GS} = 0 \text{ Vdc}, V_{DS} = 30 \text{ Vdc}, T$			_	_	10	
Gate-Body Leakage Current (V <sub>G</sub>	$_{S} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	I <sub>GSS</sub>	_	_	±100	nAdc
ON CHARACTERISTICS						
Gate Threshold Voltage		V <sub>GS(th)</sub>				Vdc
$(V_{DS} = V_{GS}, I_D = 250 \mu\text{Adc})$			1.0	1.9	3.0	
Negative Temperature Coefficient		D	_	-3.8	_	
Static Drain–Source On–State Re $(V_{GS} = 10 \text{ Vdc}, I_D = 20 \text{ Adc})$	esistance	R <sub>DS(on)</sub>	_	0.0078	0.010	Ω
$(V_{GS} = 10 \text{ Vdc}, I_D = 10 \text{ Adc})$			_	0.0078	0.010	
$(V_{GS} = 4.5 \text{ Vdc}, I_D = 5.0 \text{ Adc})$			-	0.010	0.013	
Forward Transconductance (V <sub>DS</sub>	= 15 Vdc, I <sub>D</sub> = 10 Adc)	gFS	-	20	-	Mhos
DYNAMIC CHARACTERISTICS		<b>.</b>	_	1		1
Input Capacitance	(\/ 24 \/do \/ 0 \/do	C <sub>iss</sub>	-	2050	2400	pF
Output Capacitance	$(V_{DS} = 24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	Coss	_	640	800	
Reverse Transfer Capacitance	,	C <sub>rss</sub>	_	225	310	
SWITCHING CHARACTERISTICS	(Note 6)			_		
Turn-On Delay Time		t <sub>d(on)</sub>	_	11	20	ns
Rise Time	$(V_{DD} = 25 \text{ Vdc}, I_{D} = 1.0 \text{ Adc}, V_{GS} = 10 \text{ Vdc},$	t <sub>r</sub>	_	15	25	
Turn-Off Delay Time	$R_G = 6.0 \Omega$	t <sub>d(off)</sub>	_	85	130	
Fall Time	,	t <sub>f</sub>	-	55	90	
Turn-On Delay Time		t <sub>d(on)</sub>	-	11	20	ns
Rise Time	$(V_{DD} = 25 \text{ Vdc}, I_D = 1.0 \text{ Adc}, V_{GS} = 10 \text{ Vdc},$	t <sub>r</sub>	_	13	20	
Turn-Off Delay Time	$R_G = 2.5 \Omega$	t <sub>d(off)</sub>	-	55	90	
Fall Time	,	t <sub>f</sub>	-	40	75	
Turn-On Delay Time		t <sub>d(on)</sub>	-	15	_	ns
Rise Time	$(V_{DD} = 24 \text{ Vdc}, I_D = 20 \text{ Adc},$	t <sub>r</sub>	-	25	_	
Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc},$ $R_G = 2.5 \Omega)$	t <sub>d(off)</sub>	_	40	ı	
Fall Time	,	t <sub>f</sub>	-	58	ı	
Gate Charge		$Q_{T}$	_	55	80	nC
	$(V_{DS} = 24 \text{ Vdc}, I_D = 2.0 \text{ Adc}, V_{GS} = 10 \text{ Vdc})$	Q <sub>gs</sub> (Q1)	_	5.5	_	
	v <sub>GS</sub> = 10 vdc)		_	15	-	
BODY-DRAIN DIODE RATINGS (I	Note 5)					
Diode Forward On-Voltage		V <sub>SD</sub>				Vdc
$(I_S = 2.3 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$		_	0.75	1.0		
$(I_S = 20 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 2.3 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J)$		_	0.90 0.65	_		
Reverse Recovery Time	t <sub>rr</sub>	_	39	65	ns	
	$(I_S = 2.3 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$	ta	_	20	_	- 113
	$dI_{S}/dt = 100 \text{ A/}\mu\text{s})$	t <sub>b</sub>	_	19	_	1
		1 °U	•			•

<sup>5.</sup> Indicates Pulse Test: Pulse Width = 300 µsec max, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperature.

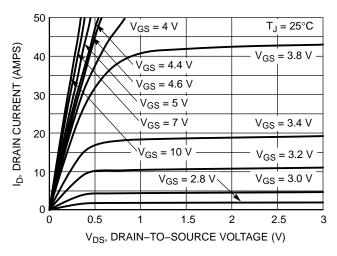


Figure 1. On-Region Characteristics

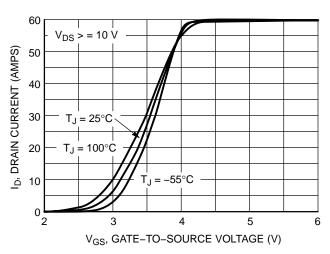


Figure 2. Transfer Characteristics

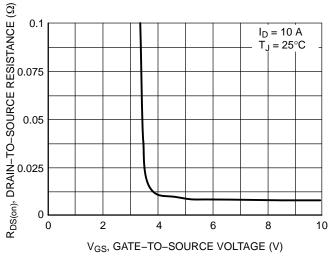


Figure 3. On–Resistance vs. Gate–To–Source Voltage

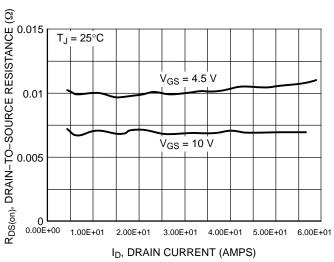


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

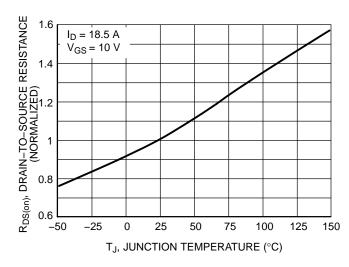


Figure 5. On–Resistance Variation with Temperature

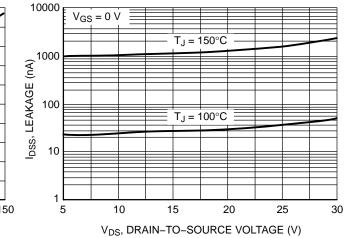


Figure 6. Drain-To-Source Leakage Current vs. Voltage

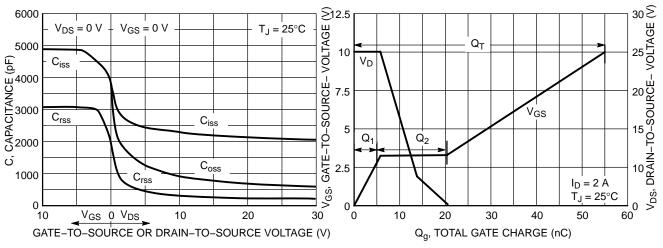


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

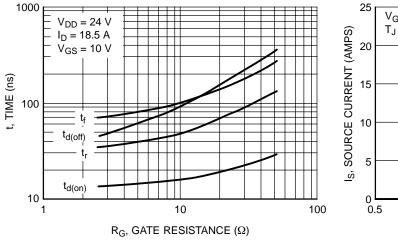


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

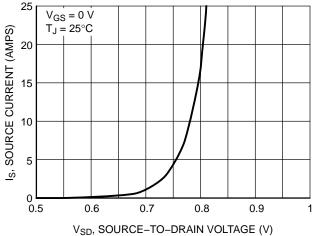
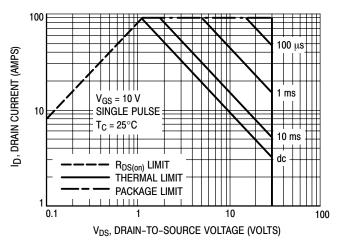


Figure 10. Diode Forward Voltage vs. Current



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Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Diode Reverse Recovery Waveform

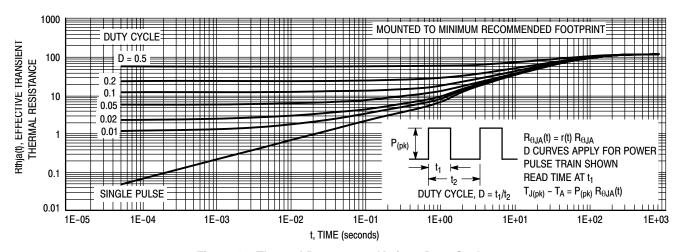


Figure 13. Thermal Response - Various Duty Cycles

# **ORDERING INFORMATION**

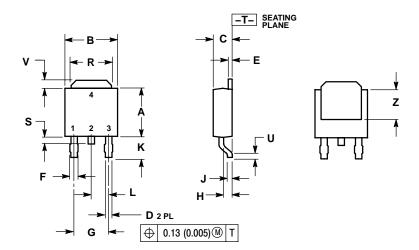
Device	Package Type	Package	Shipping <sup>†</sup>
NTD4302	DPAK	369C	75 Units / Rail
NTD4302G	DPAK	369C (Pb-Free)	75 Units / Rail
NTD4302-001	DPAK-3	369D	75 Units / Rail
NTD4302-1G	DPAK-3	369D (Pb-Free)	75 Units / Rail
NTD4302T4	DPAK	369C	2500 Tape & Reel
NTD4302T4G	DPAK	369C (Pb-Free)	2500 Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **PACKAGE DIMENSIONS**

## **DPAK**

CASE 369C-01 **ISSUE O** 

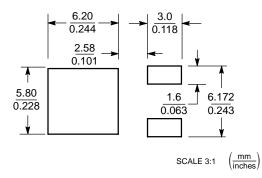


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.180	BSC	4.58 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.090 BSC		2.29	2.29 BSC	
R	0.180	0.215	4.57	5.45	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
V	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

## **SOLDERING FOOTPRINT\***

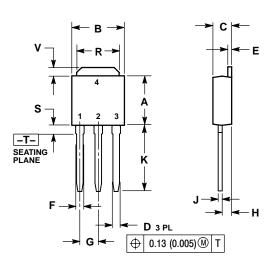


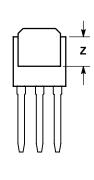
<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# PACKAGE DIMENSIONS

#### **DPAK**

CASE 369D-01 ISSUE B





#### NOTES:

- DIMENSIONING AND TOLERANCING PER
   ANSI V14 5M 1982
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090 BSC		2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

# STYLE 2:

- PIN 1. GATE
  - 2. DRAIN
  - 3. SOURCE
  - 4. DRAIN

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